

## IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components, Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

## Schedule of Scope to Certificate of Approval

**Independent Testing Laboratory** 

IECQ Certificate No.: IECQ-L DEKRA 17.0002
CB Certificate No.: DEKRA-C8-001

Schedule Number: IECQ-L DEKRA 17.0002-S Rev No.: 1 Revision Date: 2017/06/09 Page 1 of 1

1. Environmental and reliability testing, inspection and failure analysis of Electronic Components, Assemblies, and Related Materials

Description test	Standard	Remarks
External Visual, High Temperature test, High Temperature High Humidity test, Humidity test, Low Temperature test, Gas Corrosion test, Power and Temperature Cycle test, Temperature and Humidity Cycle test, LED (LEDs Package, Module, Array) Lumen maintenance	JESD22 B-101,AECQ-101, IEC60810, MIL-STD-202, Method 103/106, MIL-STD-810, Method 507, MIL-STD-883,Method 1004, JESD22-A101-B,IEC 60068-2-78, EIA-364-17B,IEC 60068-2-2, MIL-STD-202, Method 108, MIL-STD-810, Method 501/502, MIL-STD-810 Method 502.4, MIL-STD-883 Method 1008.2, IEC 60068-2-43/60,JIS C 0092, MIL-STD-883 Method 2018.4, JESD201,IEC 60068-2-14, JESD22 A-101/119/103/104/108/ 113/100/105/121, JESD J-STD 020,IES LM-80	Or customer specified test



